Search Notes



| Application/Control No. | Applicant(s)/Patent Under Reexamination |
|-------------------------|--|
| 10714654 | TAKEKOSHI ET AL. |
| Examiner | Art Unit |
| RANDOLPH CHU | 2624 |

| | SEARCHED | | | | | |
|-------|----------|-----------|----------|--|--|--|
| Class | Subclass | Date | Examiner | | | |
| 382 | 100, 128 | 6/6/2007 | ric | | | |
| 705 | 2.3 | 6/6/2007 | ric | | | |
| 715 | 716 | 3/20/2008 | ric | | | |
| 707 | 2 | 3/20/2008 | ric | | | |

| SEARCH NOTES | | | | |
|---------------------------|-----------|----------|--|--|
| Search Notes | Date | Examiner | | |
| EAST | 6/6/2007 | ric | | |
| Inventor Name Search | 6/6/2007 | ric | | |
| Consult with Wenpeng Chen | 6/6/2007 | ric | | |
| Updated EAST Search | 12/7/2007 | ric | | |
| Updated EAST Search | 3/20/2008 | ric | | |

| INTERFERENCE SEARCH | | | | | | | | |
|---------------------|----------|------|----------|--|--|--|--|--|
| Class | Subclass | Date | Examiner | | | | | |
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